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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

patent application of:)	
the particular of particular o)	Before the Examiner
David W. Burke et al.)	
)	Not Yet Assigned
Serial No. 10/688,561)	
₩)	Group Art Unit 3736
Filed October 17, 2003)	
9)	
SYSTEM AND METHOD FOR)	
DETERMINING AN ABUSED SENSOR)	
DURING ANALYTE MEASUREMENT)	February 11, 2005

INFORMATION DISCLOSURE STATEMENT

MAIL STOP AMENDMENT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure in accordance with 37 C.F.R. §1.56, Applicant wishes to bring to the attention of the Examiner the items of information listed on the enclosed Information Disclosure Citation Form. This information has not been previously submitted in this application, and has not been heretofore cited previously by the Examiner. Copies of all foreign patent documents and non-patent literature are enclosed in accordance with 37 CFR 1.98(a). Copies of cited U.S. patents and patent applications are not enclosed pursuant to 37 CFR 1.491(b).

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on

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Date of Deposit

Troy J. Cole

Name of Registered Representative

Signature

February 11, 2005

Date of Signature

For items of information contained in this Statement that are not in the English language, under §1.98(a)(3)(i) these items are understood to be relevant in that they relate to biosensors and were included in the results of searches conducted on behalf of Applicants.

The filing of this Information Disclosure Statement shall not be construed as an admission that the information cited is, or is considered to be, material to patentability as defined in §1.56(b).

This Statement is being submitted prior to the mailing of any Office Action on the merits. It is believed that no fee is required for consideration of the submitted items. However, should any fees be deemed required, the Commissioner is authorized to charge such fees to Deposit Account No. 23-3030, but is not to include payment of issue fees.

Respectfully submitted

Bv:

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	for form 1449A	EMARK	Complete if Known				
Substitute	tor form 1449A	1210	Application Number	10/688,561			
INFORMATION DISCLOSURE		DISCLOSURE	Filing Date	October 17, 2003			
STA	TEMENT B	Y APPLICANT	First Named Inventor	David W. Burke			
		Group Art Unit	3736				
(u	ise as many she	ets as necessary)	Examiner Name				
Sheet	1	of 38	Attorney Docket Number	7404-556			

U.S. PATENT DOCUMENTS							
Examiner Cite Initials* No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
		3,526,480	09/01/1970	Findl et al.			
		3,551,295	12/29/1970	Dyer			
		3,621,381	11/16/1971	Eckfeldt			
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		4,053,381	10/11/1977	Hamblen et al.			

Examiner	Cite	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials*	No.'	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-TTTT	Document	Figures Appear	<u> </u>
		AU 737 787	08/30/2001	Batman et al.	<u> </u>	
		DE 36 43 263	07/07/1988	Hommel Host		
		DE 40 11 428 A1	11/29/1990	Kühn et al.		
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		DE 199 36 693	02/08/2001	LRE		
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		EP 0 034 049	08/19/1981	Columbus		<u> </u>
		EP 0 057 110	08/04/1982	Columbus		

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		4,065,263	12/27/1977	Woodbridge, III			
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Initials*	No.	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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		EP 0 171 148	02/12/1986	Shanks et al.		
		EP 0 171 239	02/12/1986	Ikeda et al.		

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ι			contormance and not considered. Include

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Sheet	3	of	38	Attornev Docket Number	7404-556		

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		4,303,887	12/01/1981	Hill et al.			
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	NO.	Country Code"-Number -Kind Code" (if Known)			rigules Appeal	\vdash
		EP 0 186 286	07/02/1986	Nylander et al.		
		EP 0 206 218 B1	06/03/1991	Wogoman		
		EP 0 213 343 B2	02/01/1995	Young et al.		
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		EP 0 255 291 B1	06/24/1992	Birch et al.		
		EP 0 287 883	10/26/1988	Blatt		

Examiner	Date
Signature	Considered

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ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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		EP 0 417 796 B1	11/23/1994	Ishihara et al.		
		EP 0 470 649 B1	06/02/1999	Unilever et al.		<u> </u>
		EP 0 471 986 A2	02/26/1992	Nankai et al.		
		EP 0 471 986 A3	04/29/1992	Nankai et al.		
		EP 0 471 986 B1	10/18/1995	Nankai et al.		
		EP 0 537 761 A3	02/02/1994	Yoshioka et al.		

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IIIIIII		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)		Document	Figures Appear	₩
		EP 0 537 761 B1	08/27/1997	Yoshioka et al.		↓
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		EP 0 741 186 B1	10/17/2001	Genshaw et al.		

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		EP 0 894 509 A2	02/03/1999	Herman		

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		EP 1 067 384 A2	01/10/2001	Ohara et al.		

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Complete if Known Substitute for form 1449A/PTO **Application Number** 10/688,561 INFORMATION DISCLOSURE October 17, 2003 Filing Date STATEMENT BY APPLICANT First Named Inventor David W. Burke 3736 Group Art Unit (use as many sheets as necessary) **Examiner Name** Attornev Docket Number 7404-556 38 Sheet of

			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relovant
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,		EP 1 143 245	10/10/2001	Roche		

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Substitute	e for form 1449A	PIO		Application Number	10/688,561
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003
STA	ATEMENT E	BY AP	PLICANT	First Named Inventor	David W. Burke
				Group Art Unit	3736
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Sheet	9	of	38	Attornev Docket Number	7404-556

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Examiner Initials*	Cite No.1	Document Number	Publication Date	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁴
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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INFO	RMATION	DISCL	OSURE	Filing Date	October 17, 2003		
STA	TEMENT B	Y APP	LICANT	First Named Inventor	David W. Burke		
		_	,	Group Art Unit	3736		
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Sheet	10	of	38	Attornev Docket Number	7404-556		

Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear	
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Substitute	Substitute for form 1449A/PTO			Application Number	10/688,561		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	11	of	38	Attornev Docket Number	7404-556		

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	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	12	of	38	Attornev Docket Number	7404-556		

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INFO	RMATION D	DISC	LOSURE	Filing Date	October 17, 2003	
STAT	TEMENT BY	/ AP	PLICANT	First Named Inventor	David W. Burke	
				Group Art Unit	3736	
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				Group Art Unit	3736		
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Initials* No.1		Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear	
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		5,719,667	02/17/1998	Miers		
		5,720,862	02/24/1998	Hamamoto et al.		
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		5,727,548	03/17/1998	Hill et al.		
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		5,759,794	06/02/1998	Levine et al.		

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T [©]
Initials* No.1		Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 86/07632	12/31/1986	Nankai et al.		
		WO 89/08713	09/21/1989	Pottgenea		
		WO 89/09397	10/05/1989	Nankai et al.		
		WO 90/05293	05/17/1990	Michel		
		WO 92/01928	02/06/1992	Cozzette et al.		
		WO 92/07655	05/14/1992	Cox et al.		
		WO 92/15859	09/17/1992	Adrian et al.		
		WO 92/15861	09/17/1992	Grant et al.		

Examiner Signature			Date Considered	

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¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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Complete if Known Substitute for form 1449A/PTO Application Number 10/688,561 INFORMATION DISCLOSURE October 17, 2003 Filing Date STATEMENT BY APPLICANT First Named Inventor David W. Burke 3736 **Group Art Unit** (use as many sheets as necessary) **Examiner Name** 7404-556 Attornev Docket Number Sheet 38 of

			U.S. PATEN	U.S. PATENT DOCUMENTS						
Examiner Cite Initials* No.		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear					
		5,762,770	06/09/1998	Pritchard et al.						
		5,776,710	07/07/1998	Levine et al.						
		5,780,304	07/14/1998	Matzinger et al.						
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		5,789,255	08/04/1998	Yu						
		5,792,668	08/11/1998	Deamer et al.						
		5,798,031	08/25/1998	Charlton et al.						
		5,801,057	09/01/1998	Smart et al.						
		5,820,551	10/13/1998	Hill et al.						
		5,820,622	10/13/1998	Gross et al.						
		5,832,921	11/10/1998	Lennert et al.						
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		5,837,546	11/17/1998	Allen et al.						
		5,843,691	12/01/1998	Douglas et al.						
		5,843,692	12/01/1998	Phillips et al.						
		5,846,744	12/08/1998	Athey et al.						
		5,849,174	12/15/1998	Sanghera et al.						

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials* No.1		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 92/15950	09/17/1992	Arbuckle et al.		
		WO 92/22669	12/23/1992	Gullick		
		WO 93/09433	05/13/1993	Gharib		
		WO 94/12950	06/09/1994	Holmes et al.		
		WO 94/16095	07/21/1994	Zweig		
		WO 94/23295	10/13/1994	McAleer et al.		
		WO 94/28414	12/08/1994	Athey et al.		
		WO 94/29705	12/22/1994	White et al.		

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				Complete if Known			
Substitute	Substitute for form 1449A/PTO		Application Number	10/688,561			
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. Burke		
_				Group Art Unit	3736		
(1	use as many shee	ts as r	necessary)	Examiner Name			
Sheet	16	of	38	Attornev Docket Number	7404-556		

U.S. PATENT DOCUMENTS						
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear	
		5,856,195	01/05/1999	Charlton et al.		
		5,873,990	02/23/1999	Wojciechowski et al.		
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		5,911,872	06/15/1999	Lewis et al.		
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		5,948,289	09/07/1999	Noda et al.		
		5,951,836	09/14/1999	McAleer et al.		
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		5,971,923	10/26/1999	Finger		

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 95/03542	02/02/1995	Scott et al.		
		WO 95/06919	03/09/1995	Collins et al.		
		WO 95/07050	03/16/1995	Lennert et al.		
		WO 95/22597	08/24/1995	Diebold et al.		<u>L</u>
		WO 96/04398	02/15/1996	Sanghera et al.		1
		WO 96/07908	03/14/1996	Matzinger et al.		
		WO 96/13707	05/09/1996	Connolly		
		WO 96/15454	05/23/1996	Braach-		

Examiner Signature	Date Considered	

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			<u> </u>	Complete if Known			
Substitute	for form 1449A/i	210		Application Number	10/688,561		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	17	of	38	Attornev Docket Number	7404-556		

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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear	
		5,989,917	11/23/1999	McAleer et al.		
		5,997,817	12/07/1999	Crismore et al.		
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	Τ ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 96/33403	10/24/1996	Higson		
		WO 97/00441	01/03/1997	Hodges et al.		
	WO 97/02487		01/23/1997	Pritchard et al.		
		WO 97/08544	03/06/1997	Wojciechowski		
		WO 97/16726	05/09/1997	Sullivan		
		WO 97/18465	05/22/1997	Hodges et al.		
		WO 97/29366	08/14/1997	Braach-		
		WO 97/29847	08/21/1997	McAleer et al.		

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				Complete if Known			
Substitut	e for form 1449A/i	210		Application Number	10/688,561		
	ORMATION			Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
(use as many shee	ets as r	ecessary)	Examiner Name			
Sheet	18	of	38	Attornev Docket Number	7404-556		

U.S. PATENT DOCUMENTS						
Examiner	Cite No.1	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	No.'	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear	
		6,129,823	10/10/2000	Hughes et al.		
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 97/30344	08/21/1997	McAleer et al.		<u> </u>
		WO 97/39341	10/29/1997	Fuller et al.		
		WO 97/39343	10/23/1997	Garnham et al.		
		WO 97/42882	11/20/1997	Douglas et al.		
		WO 97/42888	11/20/1997	Douglas et al.		
		WO 97/45719	12/04/1997	Kessler		
		WO 98/05424	02/12/1998	Chow		
		WO 98/19153	05/07/1998	Vadgama et al.		

Examiner Signature	Date Considered	

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Cubatituta	for form 1440A/F)TO		Complete if Known			
Substitute	for form 1449A/F	P10		Application Number	10/688,561		
INFO	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	TEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
		4		Group Art Unit	3736		
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Sheet	19	of	38	Attornev Docket Number	7404-556		

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant	
Initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear	
		6,170,318	01/09/2001	Lewis		
		6,174,420	01/16/2001	Hodges et al.		
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials* No. ¹		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 98/19159	05/07/1998	Douglas et al.		
		WO 98/29740	07/09/1998	Clerc et al.		
		WO 98/35225	08/13/1998	Heller et al.		
		WO 98/55853	12/10/1998	Altin et al.		
		WO 98/57159	12/17/1998	O'Conner et al.		
		WO 99/05516	04/02/1999	Kawanaka et al.		
		WO 99/05966	02/11/1999	Alton et al.		
		WO 99/09404	02/25/1999	Maxwell et al.		

Examiner Signature	Date Considered

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Substitute to	or form 1449A	VPIO		Application Number	10/688,561		
INFO	RMATION	I DISCL	.OSURE	Filing Date	October 17, 2003		
STAT	EMENT E	BY APP	LICANT	First Named Inventor	David W. Burke		
			•	Group Art Unit	3736		
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Sheet	20	of	38	Attornev Docket Number	7404-556		

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Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
		6,246,330	06/12/2001	Nielsen			
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁰
Initials* No.¹		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/12008	03/11/1999	Zweig et al.		
		WO 99/12021	03/11/1999	Han		
		WO 99/13099	03/18/1999	Hughes et al.		
		WO 99/13100	03/18/1999	Forrow et al.		
		WO 99/22236	05/06/1999	Heinonen et al.		
		WO 99/23479	05/14/1999	Weitman et al.		
		WO 99/29230	06/17/1999	Bonnecaze et		
		WO 99/30152	06/17/1999	Crismore et al.		

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Signature	Co	onsidered	+
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				Complete if Known				
Substitut	e for form 1449A/I	PTO		Application Number	10/688,561			
	ORMATION			Filing Date	October 17, 2003			
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke			
				Group Art Unit	3736			
(use as many shee	ets as n	ecessary)	Examiner Name				
Sheet	21	of	38	Attornev Docket Number	7404-556			

	U.S. PATENT DOCUMENTS							
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant			
initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear			
		6,284,550	09/04/2001	Carroll et al.				
		2001 0019831	09/06/2001	Phillips et al.				
		6,287,451	09/11/2001	Winarta et al.				
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-		6,294,281	09/25/2001	Heller				
		6,295,506	09/25/2001	Heinonen et al.				
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		6,309,526	10/30/2001	Fujiwara et al.				
		2001 0039057	11/08/2001	Douglas et al.				
		6,315,951	11/13/2001	Markart				
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		2001 0041830	11/15/2001	Varalli et al.				
		2001 0042683	11/22/2001	Musho et al.				

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/32881	07/01/1999	Beaty et al.		
		WO 99/39627	08/12/1999	Elden et al.		
,,		WO 99/41596	08/19/1999	Sumegi et al.		L.
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	Examiner Signature	Date Considered	

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Substitute	for form 1449A	PIO		Application Number	10/688,561		
INF	ORMATION	DISCLO	DSURE	Filing Date	October 17, 2003		
STA	ATEMENT E	BY APPL	ICANT.	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	22	of	38	Attornev Docket Number	7404-556		

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INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	23	of	38	Attornev Docket Number	7404-556		

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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number Complete if Known Substitute for form 1449A/PTO **Application Number** 10/688,561 INFORMATION DISCLOSURE October 17, 2003 Filing Date STATEMENT BY APPLICANT First Named Inventor David W. Burke **Group Art Unit** 3736 (use as many sheets as necessary) **Examiner Name** 7404-556 38 Attornev Docket Number Sheet of

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Substituti	e for form 1449A/F	-10		Application Number	10/688,561		
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
,				Group Art Unit	3736		
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Sheet	25	of	38	Attornev Docket Number	7404-556	J	

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INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003			
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke			
				Group Art Unit	3736			
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Sheet	26	of	38	Attornev Docket Number	7404-556			

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INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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STA	TEMENT E	BY APP	LICANT	First Named Inventor	David W. Burke		
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Sheet	28	of	38	Attornev Docket Number	7404-556		

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		WO 02/057767 A1	07/25/2002	Watanabe et al.		

Examiner Signature	Date Considered	

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				Complete if Known				
Substitute f	for form 1449A/P	то		Application Number	10/688,561			
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003			
	TEMENT BY			First Named Inventor	David W. Burke			
				Group Art Unit	3736			
(us	se as many shee	ts as n	ecessary)	Examiner Name				
Sheet	29	of	38	Attornev Docket Number	7404-556			

U.S. PATENT DOCUMENTS								
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
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		6,565,509	05/20/2003	Say et al.				
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Examiner Cite		Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	┼
		WO 02/057768 A	07/25/2002	Iketaki Kazuo		
		WO 02/057781	07/25/2002	Khan et al.		$oxed{igspace}$
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		WO 02/06822	01/24/2002	Ratcliffe et al.		_
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		WO 02/067768	09/06/2002	Paolini et al.		
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		WO 02/071044	09/12/2002	Modzelewski et		<u> </u>

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Substitute fo	or form 1449A/F	то		Application Number	10/688,561	
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003	
STAT	EMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke	
				Group Art Unit	3736	
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Sheet	30	of	38	Attornev Docket Number	7404-556	

	U.S. PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear				
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 02/078512 A2	10/10/2002	Drucker et al.		
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		WO 02/097418	12/05/2002	Taniike et al.		

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Substitute	e for form 1449A/i	PIO		Application Number	10/688,561			
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003			
STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke			
				Group Art Unit	3736			
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Sheet	31	of	38	Attornev Docket Number	7404-556			

			U.S. PATEN	T DOCUMENTS	
Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
-		6,605,201	08/12/2003	Mao et al.	
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Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
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		WO 02/32559	04/25/2002	Stiene et al.		
		WO 02/48707	06/20/2002	Ohara et al.		

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Substitute fo	or form 1449A	/PTO		Application Number	10/688,561		
INFO	RMATION	I DISC	LOSURE	Filing Date	October 17, 2003		
STAT	EMENT E	3Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	32	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS	
Examiner	Cite	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	↓_
		WO 02/49507	06/27/2002	Stiene et al.		
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		WO 03/014740 A1	02/20/2003	Nadaoka et al.		
·	-	WO 03/014741 A1	02/20/2003	Takahashi et al.		<u> </u>
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Substitut	e for form 1449A/F	10		Application Number	10/688,561		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	33	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS			
Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
		2004 0005721	01/08/2004	Tanike et al.			
		6,676,995	01/13/2004	Dick et al.			
		2004 0016642	01/29/2004	Miyazaki et al.			
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.'	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 03/015629	02/27/2003	Moerman et al.		
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		WO 03/042680 A1	05/22/2003	Hasegawa et al.		
		WO 03/044513	05/30/2003	Morita et al.		

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Substitut	e for form 1449A/F	-10		Application Number	10/688,561		
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ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	34	of	38	Attornev Docket Number	7404-556		

			U.S. PATEN	T DOCUMENTS	
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials* No.1	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 03/048756 A1	06/12/2003	Yamamoto et		
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Substitute	9 for form 1449B.	VPIO		Application Number	10/688,561			
	ORMATION			Filing Date	October 17, 2003			
STA	ATEMENT B	3Y AP	PLICANT	First Named Inventor	David W. Burke			
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Sheet	35	of	38	Attorney Docket Number	7404-556			

		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS								
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Examiner	Date Considered	
Signature	Considered	

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Substitute	e for form 1449B/	PIU		Application Number	10/688,561		
	ORMATION			Filing Date	October 17, 2003		
STA	ATEMENT B	Y APPI	LICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
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Sheet	36	of	38	Attorney Docket Number	7404-556		

		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS							
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s) publisher city and/or country where published							
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Substitute	for form 1449B/f	PIO		Application Number	10/688,561		
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	TEMENT B	Y AF	PLICANT	First Named Inventor	David W. Burke		
				Group Art Unit	3736		
(us	e as many shee	ets as i	necessary)	Examiner Name			
Sheet	37	of	38	Attorney Docket Number	7404-556		

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